

<b>Notice of References Cited</b>	Application/Control No. 10/536,512		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Sin J. Lee		Art Unit 1795	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,767,689	07-2004	Pavelchek et al.	430/271.1
*	B	US-7,175,974	02-2007	Jung et al.	430/325
*	C	US-7,108,957	09-2006	Jung et al.	430/270.1
	D	US-			
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	J	US-			
	K	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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